

Report No. : EED32P80758101





## 9 PHOTOGRAPHS OF TEST SETUP



Radiated spurious emission Test Setup-1 (Below 1GHz)



Radiated spurious emission Test Setup-2 (Above 1GHz)



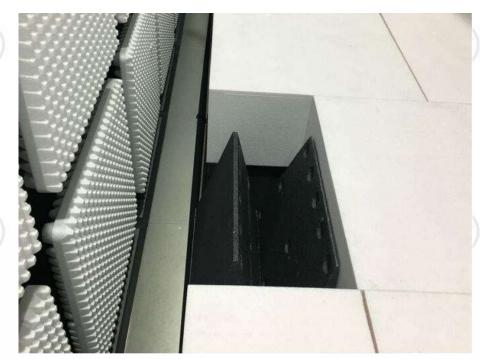


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Radiated spurious emission Test Setup-3(Above 1GHz) There are absorbing materials under the ground.

